

Notice of References Cited	Application/Control No. 10/733,122	Applicant(s)/Patent Under Reexamination FUKAYA ET AL.	
	Examiner Thong Q. Nguyen	Art Unit 2872	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-5,557,454	09-1996	Takahashi, Susumu	359/378
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	V	NONE
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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